RUMENTS

Data sheet acquired from Harris Semiconductor SCHS167E

November 1997 - Revised October 2004

Features

- HC/HCT240 Inverting
- HC/HCT241 Non-Inverting
- HC/HCT244 Non-Inverting
- Typical Propagation Delay = 8ns at V_{CC} = 5V, $C_{L} = 15 pF, T_{A} = 25^{\circ}C$ for HC240
- Three-State Outputs
- Buffered Inputs
- High-Current Bus Driver Outputs
- Fanout (Over Temperature Range)
 - Standard Outputs 10 LSTTL Loads
 - Bus Driver Outputs 15 LSTTL Loads
- Wide Operating Temperature Range -55°C to 125°C
- · Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: NIL = 30%, NIH = 30% of V_{CC} at $V_{CC} = 5V$
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility, $V_{IL} = 0.8V$ (Max), $V_{IH} = 2V$ (Min)
 - CMOS Input Compatibility, $I_I \le 1\mu A$ at V_{OL} , V_{OH}

Description

The 'HC240 and 'HCT240 are inverting three-state buffers having two active-low output enables. The CD74HC241, 'HCT241, 'HC244 and 'HCT244 are non-inverting threestate buffers that differ only in that the 241 has one activehigh and one active-low output enable, and the 244 has two active-low output enables. All three types have identical pinouts.

CD54/74HC240, CD54/74HCT240, CD74HC241, CD54/74HCT241, CD54/74HC244, CD54/74HCT244 **High-Speed CMOS Logic** Octal Buffer/Line Drivers, Three-State

Ordering Information

	TEMP. RANGE	
PART NUMBER	(°C)	PACKAGE
CD54HC240F3A	-55 to 125	20 Ld CERDIP
CD54HC244F3A	-55 to 125	20 Ld CERDIP
CD54HCT240F3A	-55 to 125	20 Ld CERDIP
CD54HCT241F3A	-55 to 125	20 Ld CERDIP
CD54HCT244F3A	-55 to 125	20 Ld CERDIP
CD74HC240E	-55 to 125	20 Ld PDIP
CD74HC240M	-55 to 125	20 Ld SOIC
CD74HC240M96	-55 to 125	20 Ld SOIC
CD74HC241E	-55 to 125	20 Ld PDIP
CD74HC241M	-55 to 125	20 Ld SOIC
CD74HC241M96	-55 to 125	20 Ld SOIC
CD74HC244E	-55 to 125	20 Ld PDIP
CD74HC244M	-55 to 125	20 Ld SOIC
CD74HC244M96	-55 to 125	20 Ld SOIC
CD74HCT240E	-55 to 125	20 Ld PDIP
CD74HCT240M	-55 to 125	20 Ld SOIC
CD74HCT240M96	-55 to 125	20 Ld SOIC
CD74HCT240PW	-55 to 125	20 Ld TSSOP
CD74HCT240PWR	-55 to 125	20 Ld TSSOP
CD74HCT240PWT	-55 to 125	20 Ld TSSOP
CD74HCT241E	-55 to 125	20 Ld PDIP
CD74HCT241M	-55 to 125	20 Ld SOIC
CD74HCT241M96	-55 to 125	20 Ld SOIC
CD74HCT244E	-55 to 125	20 Ld PDIP
CD74HCT244M	-55 to 125	20 Ld SOIC
CD74HCT244M96	-55 to 125	20 Ld SOIC

NOTE: When ordering, use the entire part number. The suffixes 96 and R denote tape and reel. The suffix T denotes a small-quantity reel of 250.

CAUTION: These devices are sensitive to electrostatic discharge. Users should follow proper IC Handling Procedures. Copyright © 2004, Texas Instruments Incorporated

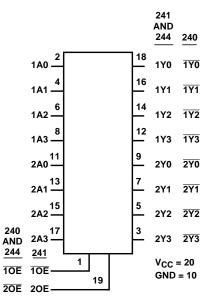
Pinout

CD54HC240, CD54HCT240, CD54HCT241, CD54HC244, CD54HCT244 (CERDIP) CD74HC240, CD74HC241, CD74HCT241, CD74HC244, CD74HCT244 (PDIP, SOIC) CD74HCT240, (PDIP, SOIC, TSSOP)

TOP VIEW

	241		241	
240	244		244	240
10E	10E 1	 20	Vcc	Vcc
1A0	1A0 2	19	20E (2	41) 20E (240, 244)
2Y3	2Y3 3	18	1Y0	1Y0
1A1	1A1 4	17	2A3	2A3
2Y2	2Y2 5	16	1Y1	<u>1Y1</u>
1A2	1A2 6	15	2A2	2A2
2Y1	2Y1 7	14	1Y2	1Y2
1A3	1A3 8	13	2A1	2A1
2Y0	2Y0 9	12	1Y3	<u>1Y3</u>
GND	GND 10	11	2A0	2A0

Functional Diagram



Absolute Maximum Ratings

DC Supply Voltage, V _{CC} 0.5V to 7V
DC Input Diode Current, I _{IK}
For $V_{I} < -0.5V$ or $V_{I} > V_{CC} + 0.5V$
DC Output Diode Current, IOK
For $V_O < -0.5V$ or $V_O > V_{CC} + 0.5V$ ±20mA
DC Drain Current, per Output, I _O
For -0.5V < V _O < V _{CC} + 0.5V±35mA
DC Output Source or Sink Current per Output Pin, IO
For $V_0 > -0.5V$ or $V_0 < V_{CC} + 0.5V$
DC V _{CC} or Ground Current, I _{CC} ±70mA

Operating Conditions

Temperature Range (T_A)
Supply Voltage Range, V _{CC}
HC Types
HCT Types4.5V to 5.5V
DC Input or Output Voltage, V _I , V _O 0V to V _{CC}
Input Rise and Fall Time
2V
4.5V 500ns (Max)
6V

Thermal Information

Thermal Resistance (Typical, Note 1)	θ_{JA}
E (PDIP) Package	69 ⁰ C/W
M (SOIC) Package	58 ⁰ C/W
PW (TSSOP) Package	83 ⁰ C/W
Maximum Junction Temperature	150 ⁰ C
Maximum Storage Temperature Range65°	C to 150 ⁰ C
Maximum Lead Temperature (Soldering 10s)	300 ⁰ C
(SOIC - Lead Tips Only)	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

		TEST CONDITION			25 ⁰ C			-40 ⁰ C 1	O 85°C	-55°С Т		
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	V _{CC} (V)	MIN	ТҮР	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES												
High Level Input	VIH	-	-	2	1.5	-	-	1.5	-	1.5	-	V
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input	V _{IL}	-	-	2	-	-	0.5	-	0.5	-	0.5	V
Voltage				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output	V _{OH}	V _{IH} or	-0.02	2	1.9	-	-	1.9	-	1.9	-	V
Voltage CMOS Loads		VIL	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output			-6	4.5	3.98	-	-	3.84	-	3.7	-	V
Voltage TTL Loads			-7.8	6	5.48	-	-	5.34	-	5.2	-	V
Low Level Output	V _{OL}	V _{IH} or	0.02	2	-	-	0.1	-	0.1	-	0.1	V
Voltage CMOS Loads		VIL	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
			0.02	6	-	-	0.1	-	0.1	-	0.1	V
Low Level Output			6	4.5	-	-	0.26	-	0.33	-	0.4	V
Voltage TTL Loads			7.8	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} or GND	-	6	-	-	±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V _{CC} or GND	0	6	-	-	8	-	80	-	160	μA

			ST ITIONS			25 ⁰ C		-40 ⁰ C 1	ГО 85 ⁰ С	-55°С т	O 125 ⁰ C	-
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	
Three-State Leakage Current	loz	V _{IL} or V _{IH}	-	6	-	-	±0.5	-	±0.5	-	±10	μA
HCT TYPES											-	
High Level Input Voltage	VIH	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	VIL	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V _{OH}	V _{IH} or V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-6	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V _{OL}	V _{IH} or V _{IL}	0.02	4.5	-	-	0.1	-	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			6	4.5	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} to GND	0	5.5	-	-	±0.1	-	±1	-	±1	μA
Quiescent Device Current	Icc	V _{CC} or GND	0	5.5	-	-	8	-	80	-	160	μA
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI _{CC} (Note 2)	V _{CC} -2.1	-	4.5 to 5.5	-	100	360	-	450	-	490	μΑ
Three-State Leakage Current	loz	V _{IL} or V _{IH}	-	5.5	-	-	±0.5	-	±5	-	±10	μA

DC Electrical Specifications (Continued)

NOTE:

2. For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

HCT Input Loading Table

UNIT LOADS
1.5
0.7
0.7
0.7
0.7
1.5
0.7
0.7
0.7

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Specifications table, e.g., $360\mu A$ max at $25^{\circ}C$.

		TEST			25 ⁰ C		-40 ⁰	с то в	35°C	-55 ⁰	С ТО 1	25 ⁰ C	
PARAMETER	SYMBOL	CONDI- TIONS	V _{CC} (V)	MIN	ТҮР	МАХ	MIN	ТҮР	МАХ	MIN	ТҮР	мах	UNITS
HC TYPES													
Propagation Delay	t _{PLH} , t _{PHL}	$C_L = 50 pF$											
Data to Outputs			2	-	-	100	-	-	125	-	-	150	ns
HC240			4.5	-	-	20	-	-	25	-	-	30	ns
		C _L = 15pF	5	-	8	-	-	-	-	-	-	-	ns
		$C_L = 50 pF$	6	-	-	17	-	-	21	-	-	26	ns
Data to Outputs	t _{PLH} , t _{PHL}	$C_L = 50 pF$	2	-	-	110	-	-	140	-	-	165	ns
HC241			4.5	-	-	22	-	-	28	-	-	33	ns
		C _L = 15pF	5	-	9	-	-	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	19	-	-	24	-	-	28	ns
Data to Outputs	t _{PLH} , t _{PHL}	$C_L = 50 pF$	2	-	-	110	-	-	140	-	-	165	ns
HC244			4.5	-	-	22	-	-	28	-	-	33	ns
		C _L = 15pF	5	-	9	-	-	-	-	-	-	-	ns
		C _L = 50pF	6	-	-	19	-	-	24	-	-	28	ns
Output Enable and Disable	t _{THL} , t _{TLH}	$C_L = 50 pF$	2	-	-	150	-	-	190	-	-	225	ns
Time			4.5	-	-	30	-	-	38	-	-	45	ns
			5	-	12	-	-	-	-	-	-	-	ns
			6	-	-	26	-	-	33	-	-	38	ns
Output Transition Time	t _{TLH} , t _{THL}	C _L = 50pF	2	-	-	60	-	-	75	-	-	90	ns
		_ .	4.5	-	-	12	-	-	15	-	-	18	ns
			6	-	-	10	-	-	13	-	-	15	ns
Input Capacitance	Cl	C _L = 50pF	-	10	-	10	-	-	10	-	-	10	pF
Three-State Output Capacitance	C _O	$C_L = 50 pF$	-	-	-	20	-	-	20	-	-	20	pF
Power Dissipation Capacitance	C _{PD}	C _L = 15pF											
(Notes 3, 4)			_										_
HC240			5	-	38	-	-	-	-	-	-	-	pF
HC241			5	-	34	-	-	-	-	-	-	-	pF
HC244			5	-	46	-	-	-	-	-	-	-	pF
HCT TYPES			-	1	1				1				
Propagation Delay													
Data to Outputs HCT240	t _{PHL} , t _{PLH}	$C_L = 50 pF$	4.5	-	-	22	-	-	28	-	-	33	ns
		C _L = 15pF	5	-	9	-	-	-	-	-	-	-	ns
Data to Outputs HCT241	^t PHL, ^t PLH	$C_L = 50 pF$	4.5	-	-	25	-	-	31	-	-	38	ns
		C _L = 15pF	5	-	10	-	-	-	-	-	-	-	ns
Data to Outputs HCT244	t _{PHL} , t _{PLH}	$C_L = 50 pF$	4.5	-	-	25	-	-	31	-	-	38	ns
		$C_L = 15 pF$	5	-	10	-	-	-	-	-	-	-	ns

Switching Specification • C. -

		TEST		25 ⁰ C			-40 ⁰ C TO 85 ⁰ C			-55 ⁰ (25 ⁰ C		
PARAMETER	SYMBOL	CONDI- TIONS	V _{CC} (V)	MIN	ТҮР	МАХ	MIN	ТҮР	MAX	MIN	ТҮР	МАХ	UNITS
Output Enable and Disable Times	t _{TLH} , t _{THL}	C _L = 50pF	4.5	-	-	30	-	-	38	-	-	45	ns
Output Transition Time	t _{THL} , t _{TLH}	$C_L = 50 pF$	4.5	-	-	12	-	-	15	-	-	18	ns
Input Capacitance	Cl	$C_L = 50 pF$	-	10	-	10	-	-	10	-	-	10	pF
Power Dissipation Capacitance (Notes 3, 4)	C _{PD}												
HCT240		-	5	-	40	-	-	-	-	-	-	-	pF
HCT241		-	5	-	38	-	-	-	-	-	-	-	pF
HCT244		-	5	-	40	-	-	-	-	-	-	-	pF

Switching Specifications $C_L = 50 pF$, Input t_r , $t_f = 6 ns$ (Continued)

NOTES:

3. C_{PD} is used to determine the dynamic power consumption, per channel.

4. $P_D = V_{CC}^2 f_i (C_{PD} + C_L)$ where f_i = Input Frequency, f_O = Output Frequency, C_L = Output Load Capacitance, V_{CC} = Supply Voltage.

Test Circuits and Waveforms

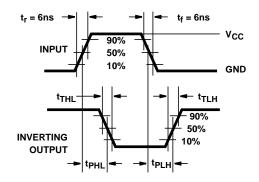
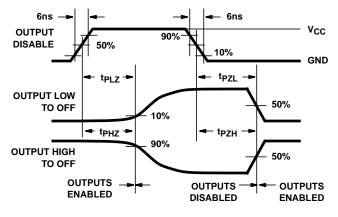


FIGURE 1. HC TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC





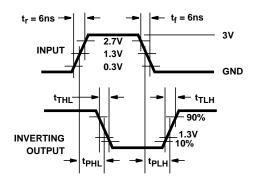


FIGURE 2. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

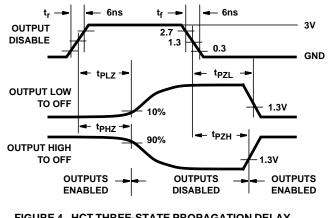
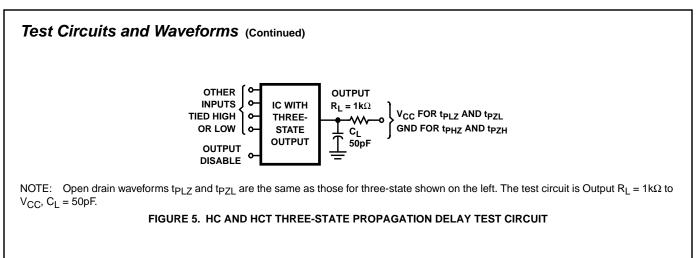


FIGURE 4. HCT THREE-STATE PROPAGATION DELAY WAVEFORM





10-Jun-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	•	Pins	•		Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD54HC240F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8407401RA CD54HC240F3A	Samples
CD54HC244F	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HC244F	Samples
CD54HC244F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8409601RA CD54HC244F3A	Samples
CD54HCT240F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8550501RA CD54HCT240F3A	Samples
CD54HCT241F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HCT241F3A	Samples
CD54HCT244F	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD54HCT244F	Samples
CD54HCT244F3A	ACTIVE	CDIP	J	20	1	TBD	A42	N / A for Pkg Type	-55 to 125	8513001RA CD54HCT244F3A	Samples
CD74HC240E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC240E	Samples
CD74HC240M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC240M	Samples
CD74HC240M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC240M	Samples
CD74HC240MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC240M	Samples
CD74HC241E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC241E	Samples
CD74HC241EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC241E	Samples
CD74HC241M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC241M	Samples
CD74HC241M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC241M	Samples
CD74HC241M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC241M	Samples
CD74HC241MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC241M	Samples



PACKAGE OPTION ADDENDUM

10-Jun-2014

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
CD74HC244E	ACTIVE	PDIP	N	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC244E	Samples
CD74HC244EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HC244E	Samples
CD74HC244M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC244M	Samples
CD74HC244M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC244M	Samples
CD74HC244M96E4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC244M	Samples
CD74HC244M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC244M	Samples
CD74HC244MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HC244M	Samples
CD74HCT240E	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT240E	Samples
CD74HCT240EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT240E	Samples
CD74HCT240M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT240M	Samples
CD74HCT240M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT240M	Samples
CD74HCT240MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT240M	Samples
CD74HCT240PW	ACTIVE	TSSOP	PW	20	70	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK240	Samples
CD74HCT240PWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK240	Samples
CD74HCT240PWT	ACTIVE	TSSOP	PW	20	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HK240	Samples
CD74HCT241E	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT241E	Samples
CD74HCT241EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT241E	Samples
CD74HCT241M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT241M	Samples



PACKAGE OPTION ADDENDUM

10-Jun-2014

Orderable Device	Status	Package Type	-	Pins	-	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CD74HCT241M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT241M	Samples
CD74HCT241M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT241M	Samples
CD74HCT241MG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT241M	Samples
CD74HCT244E	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT244E	Samples
CD74HCT244EE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD74HCT244E	Samples
CD74HCT244M	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT244M	Samples
CD74HCT244M96	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT244M	Samples
CD74HCT244M96G4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT244M	Samples
CD74HCT244ME4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	HCT244M	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



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PACKAGE OPTION ADDENDUM

10-Jun-2014

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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OTHER QUALIFIED VERSIONS OF CD54HC240, CD54HC244, CD54HCT240, CD54HCT241, CD54HCT244, CD74HC240, CD74HC244, CD74HCT240, CD74HCT241, CD74HCT244 :

• Catalog: CD74HC240, CD74HC244, CD74HCT240, CD74HCT241, CD74HCT244

• Military: CD54HC240, CD54HC244, CD54HCT240, CD54HCT241, CD54HCT244

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Military QML certified for Military and Defense Applications

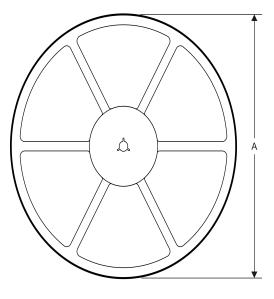
PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION

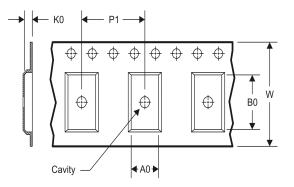
REEL DIMENSIONS

TEXAS INSTRUMENTS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD74HC240M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HC241M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HC244M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HCT240M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HCT240PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
CD74HCT240PWT	TSSOP	PW	20	250	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
CD74HCT241M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CD74HCT244M96	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1

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14-Jul-2012



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD74HC240M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HC241M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HC244M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HCT240M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HCT240PWR	TSSOP	PW	20	2000	367.0	367.0	38.0
CD74HCT240PWT	TSSOP	PW	20	250	367.0	367.0	38.0
CD74HCT241M96	SOIC	DW	20	2000	367.0	367.0	45.0
CD74HCT244M96	SOIC	DW	20	2000	367.0	367.0	45.0

J (R-GDIP-T**) 14 LEADS SHOWN

CERAMIC DUAL IN-LINE PACKAGE



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW0020A



PACKAGE OUTLINE

SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



DW0020A

EXAMPLE BOARD LAYOUT

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



DW0020A

EXAMPLE STENCIL DESIGN

SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153



LAND PATTERN DATA



NOTES: Α. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
 C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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